Search	Notes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/789,175	CAPPER ET AL.	
Examiner	Art Unit	
Edna Wong	1753	

	SEARCHED			
Class	Subclass	Date	Examiner	
205	246	3/9/2007	EW	
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	

SEAR (INCLUDING SI	CH NOTE	S TRATEGY)
		DATE	EXMR
Inventor Search		3/9/2007	EW
EAST		3/9/2007	EW
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